S	earch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/808,492	WETTSTEIN ET AL.
Examiner	Art Unit
Davin Hanna	2745

	SEARCHED				
Class	Subclass	Date	Examiner		
416	175				
	203				
	241R				
	215-218	8/26/2005	DH		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	1		

TES STRATEGY)
DATE	EXMR
8/4/2005	DH